

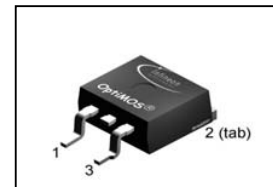
**OptiMOS<sup>®</sup> Power-Transistor**
**Features**

- N-channel - Enhancement mode
- Automotive AEC Q101 qualified
- MSL1 up to 260°C peak reflow
- 175°C operating temperature
- **Green package (lead free)**
- Ultra low Rds(on)
- 100% Avalanche tested

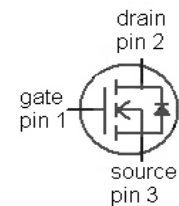
**Product Summary**

$V_{DS}$	55	V
$R_{DS(on),max}$ (SMD version)	40	mΩ
$I_D$	29	A

PG-TO252-3-11



Type	Package	Marking
IPD25N06S2-40	PG-TO252-3-11	2N0640


**Maximum ratings, at  $T_j=25\text{ °C}$ , unless otherwise specified**

Parameter	Symbol	Conditions	Value	Unit
Continuous drain current	$I_D$	$T_C=25\text{ °C}, V_{GS}=10\text{ V}$	29	A
		$T_C=100\text{ °C}, V_{GS}=10\text{ V}^{(2)}$	21	
Pulsed drain current <sup>(1)</sup>	$I_{D,pulse}$	$T_C=25\text{ °C}$	116	
Avalanche energy, single pulse	$E_{AS}$	$I_D=25\text{ A}$	80	mJ
Gate source voltage	$V_{GS}$		±20	V
Power dissipation	$P_{tot}$	$T_C=25\text{ °C}$	68	W
Operating and storage temperature	$T_j, T_{stg}$		-55 ... +175	°C
IEC climatic category; DIN IEC 68-1			55/175/56	

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	

**Thermal characteristics**

Thermal resistance, junction - case	$R_{thJC}$		-	-	2.2	K/W
Thermal resistance, junction - ambient, leaded	$R_{thJA}$		-	-	100	
SMD version, device on PCB	$R_{thJA}$	minimal footprint	-	-	75	
		6 cm <sup>2</sup> cooling area <sup>2)</sup>	-	-	50	

**Electrical characteristics, at  $T_j=25\text{ }^\circ\text{C}$ , unless otherwise specified**
**Static characteristics**

Drain-source breakdown voltage	$V_{(BR)DSS}$	$V_{GS}=0\text{ V}, I_D=1\text{ mA}$	55	-	-	V
Gate threshold voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_D=26\text{ }\mu\text{A}$	2.1	3.0	4.0	
Zero gate voltage drain current	$I_{DSS}$	$V_{DS}=55\text{ V}, V_{GS}=0\text{ V}, T_j=25\text{ }^\circ\text{C}$	-	0.01	1	$\mu\text{A}$
		$V_{DS}=55\text{ V}, V_{GS}=0\text{ V}, T_j=125\text{ }^\circ\text{C}^{1)}$	-	1	100	
Gate-source leakage current	$I_{GSS}$	$V_{GS}=20\text{ V}, V_{DS}=0\text{ V}$	-	1	100	nA
Drain-source on-state resistance	$R_{DS(on)}$	$V_{GS}=10\text{ V}, I_D=13\text{ A}$	-	28.6	40	m $\Omega$

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	

**Dynamic characteristics<sup>1)</sup>**

Input capacitance	$C_{iss}$	$V_{GS}=0\text{ V}, V_{DS}=25\text{ V},$ $f=1\text{ MHz}$	-	513	-	pF
Output capacitance	$C_{oss}$		-	163	-	
Reverse transfer capacitance	$C_{rss}$		-	61	-	
Turn-on delay time	$t_{d(on)}$	$V_{DD}=30\text{ V}, V_{GS}=10\text{ V},$ $I_D=25\text{ A}, R_G=22\ \Omega$	-	8	-	ns
Rise time	$t_r$		-	20	-	
Turn-off delay time	$t_{d(off)}$		-	18	-	
Fall time	$t_f$		-	19	-	

**Gate Charge Characteristics<sup>1)</sup>**

Gate to source charge	$Q_{gs}$	$V_{DD}=44\text{ V}, I_D=25\text{ A},$ $V_{GS}=0\text{ to }10\text{ V}$	-	2.9	4	nC
Gate to drain charge	$Q_{gd}$		-	6.3	8	
Gate charge total	$Q_g$		-	14.0	18	
Gate plateau voltage	$V_{plateau}$		-	5.7	-	V

**Reverse Diode**

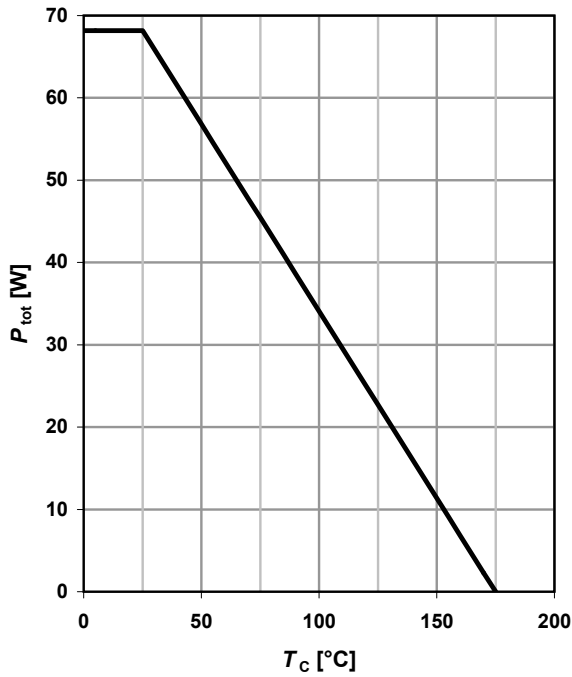
Diode continuous forward current <sup>1)</sup>	$I_S$	$T_C=25\text{ }^\circ\text{C}$	-	-	29	A
Diode pulse current <sup>1)</sup>	$I_{S,pulse}$		-	-	116	
Diode forward voltage	$V_{SD}$	$V_{GS}=0\text{ V}, I_F=25\text{ A},$ $T_j=25\text{ }^\circ\text{C}$	-	0.9	1.3	V
Reverse recovery time <sup>1)</sup>	$t_{rr}$	$V_R=30\text{ V}, I_F=I_S,$ $di_F/dt=100\text{ A}/\mu\text{s}$	-	31	-	ns
Reverse recovery charge <sup>1)</sup>	$Q_{rr}$	$V_R=30\text{ V}, I_F=I_S,$ $di_F/dt=100\text{ A}/\mu\text{s}$	-	40	-	nC

<sup>1)</sup> Defined by design. Not subject to production test.

<sup>2)</sup> Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm<sup>2</sup> (one layer, 70 μm thick) copper area for drain connection. PCB is vertical in still air.

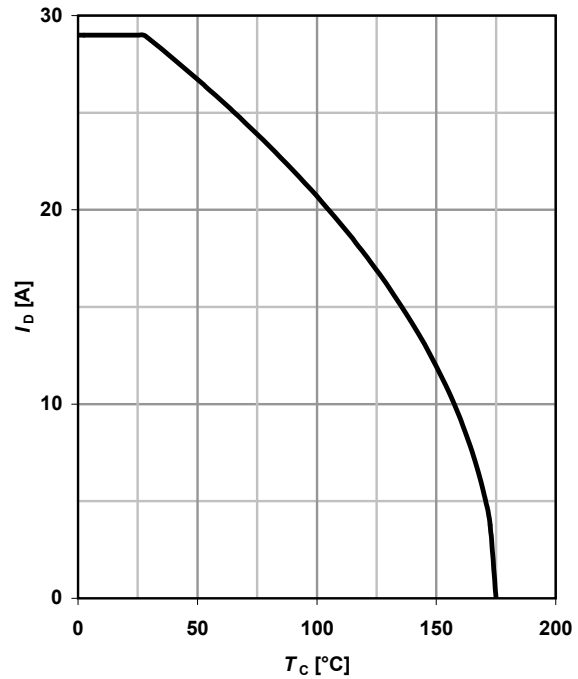
**1 Power dissipation**

$P_{tot} = f(T_C); V_{GS} \geq 6\text{ V}$



**2 Drain current**

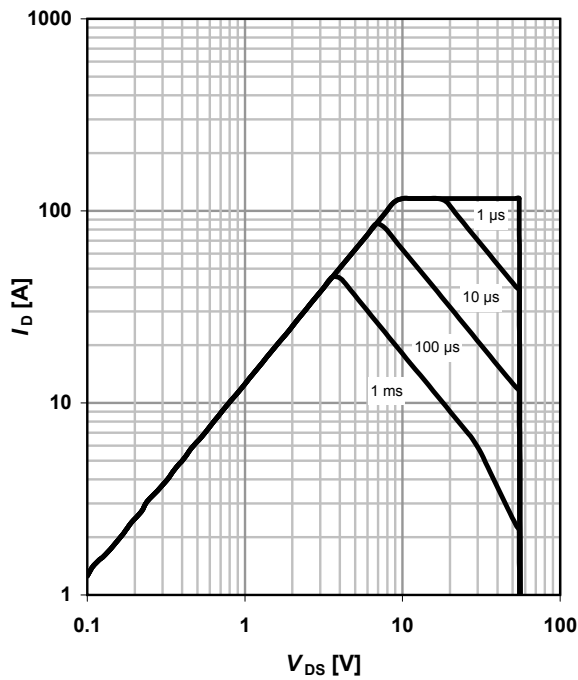
$I_D = f(T_C); V_{GS} \geq 10\text{ V}$



**3 Safe operating area**

$I_D = f(V_{DS}); T_C = 25\text{ °C}; D = 0$

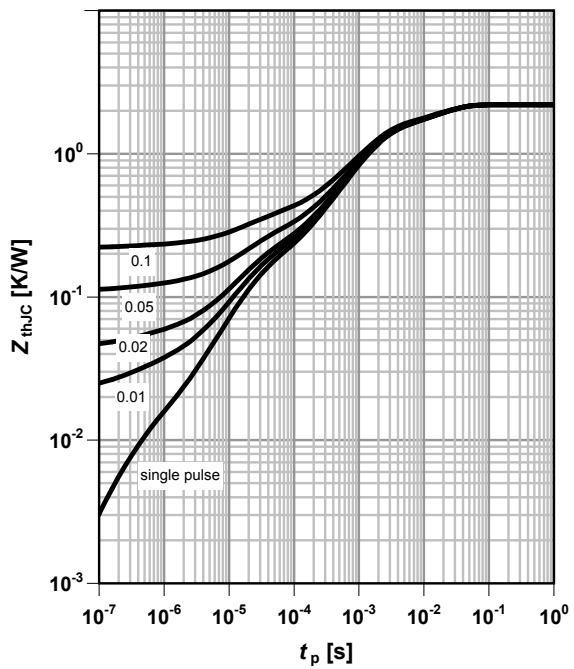
parameter:  $t_p$



**4 Max. transient thermal impedance**

$Z_{thJC} = f(t_p)$

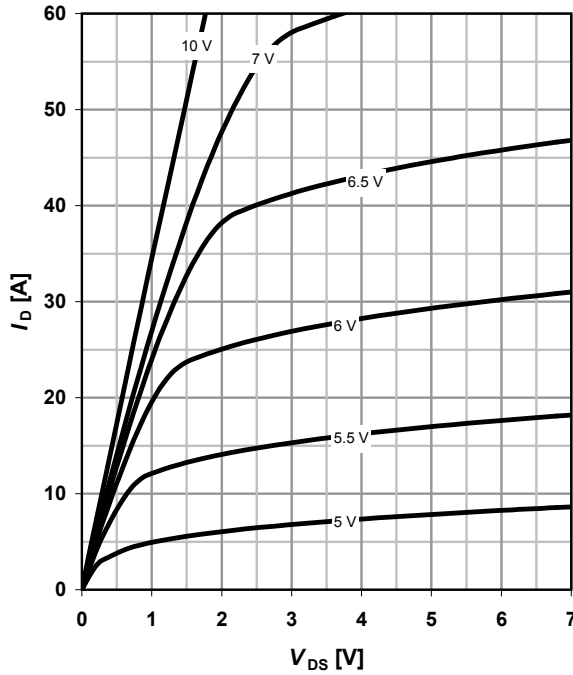
parameter:  $D = t_p/T$



**5 Typ. output characteristics**

$I_D = f(V_{DS}); T_j = 25\text{ °C}$

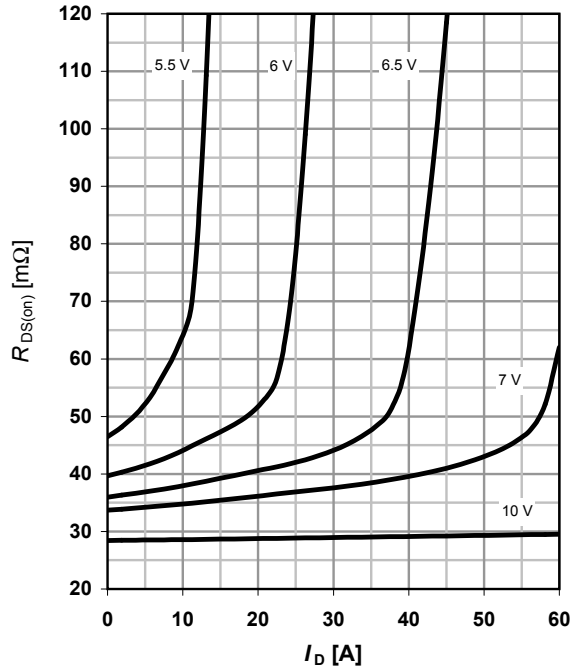
parameter:  $V_{GS}$



**6 Typ. drain-source on-state resistance**

$R_{DS(on)} = f(I_D); T_j = 25\text{ °C}$

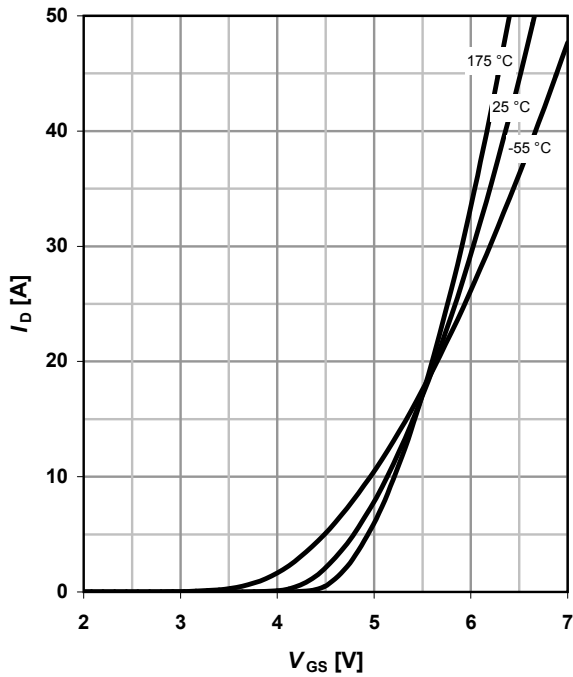
parameter:  $V_{GS}$



**7 Typ. transfer characteristics**

$I_D = f(V_{GS}); V_{DS} = 6V$

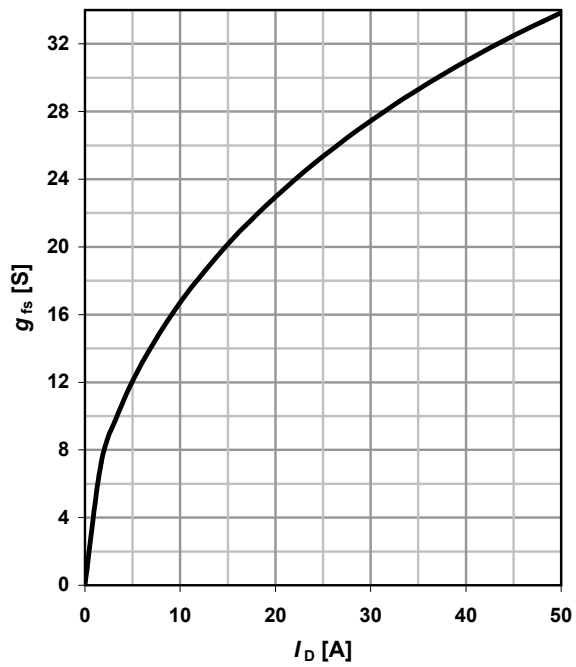
parameter:  $T_j$



**8 Typ. Forward transconductance**

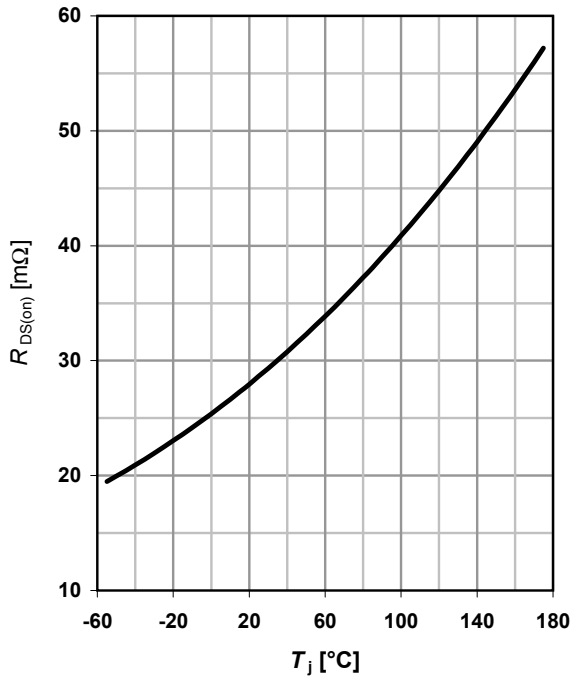
$g_{fs} = f(I_D); T_j = 25\text{ °C}$

parameter:  $g_{fs}$

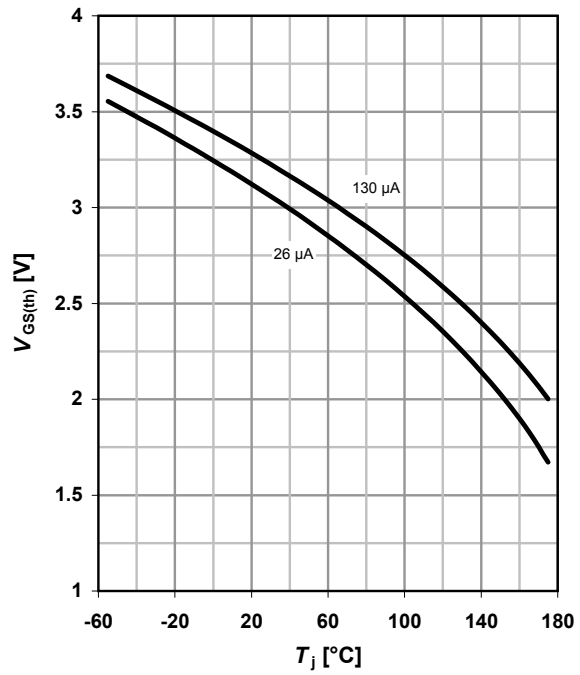


**9 Typ. Drain-source on-state resistance**

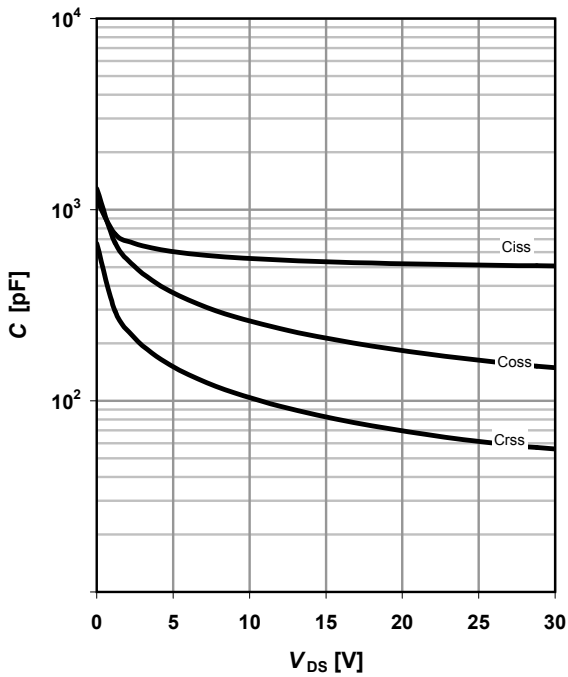
$$R_{DS(on)} = f(T_j)$$

 parameter:  $I_D = 13 \text{ A}$ ;  $V_{GS} = 10 \text{ V}$ 

**10 Typ. gate threshold voltage**

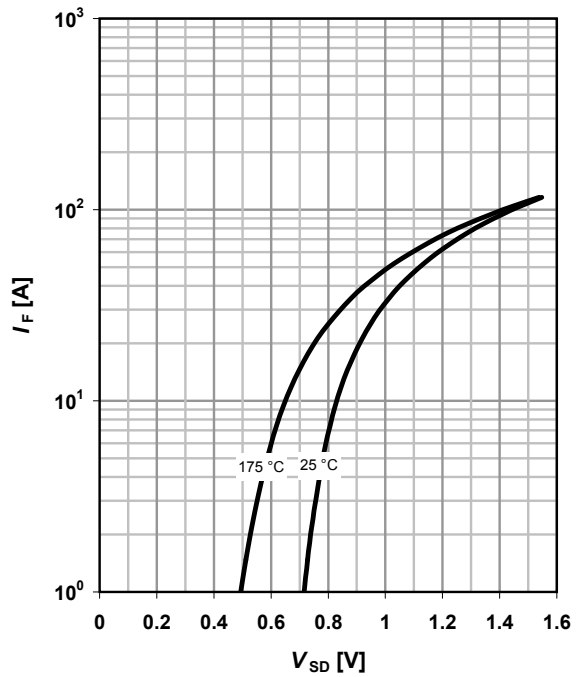
$$V_{GS(th)} = f(T_j); V_{GS} = V_{DS}$$

 parameter:  $I_D$ 

**11 Typ. capacitances**

$$C = f(V_{DS}); V_{GS} = 0 \text{ V}; f = 1 \text{ MHz}$$


**12 Typical forward diode characteristics**

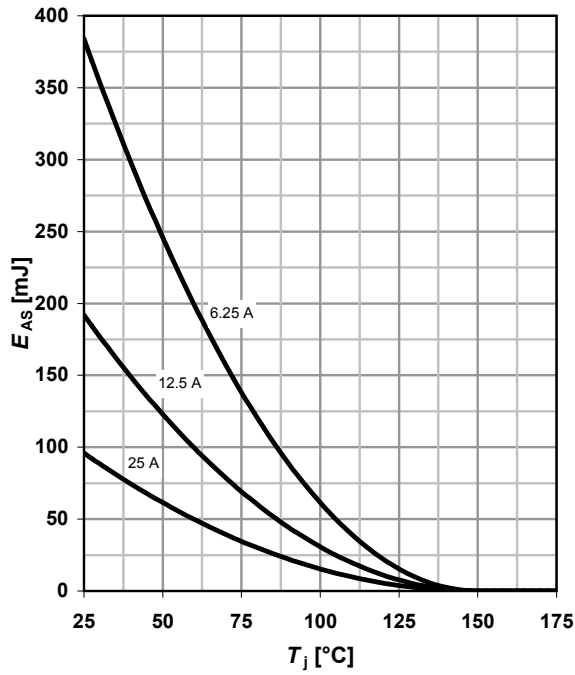
$$I_F = f(V_{SD})$$

 parameter:  $T_j$ 


**13 Typical avalanche energy**

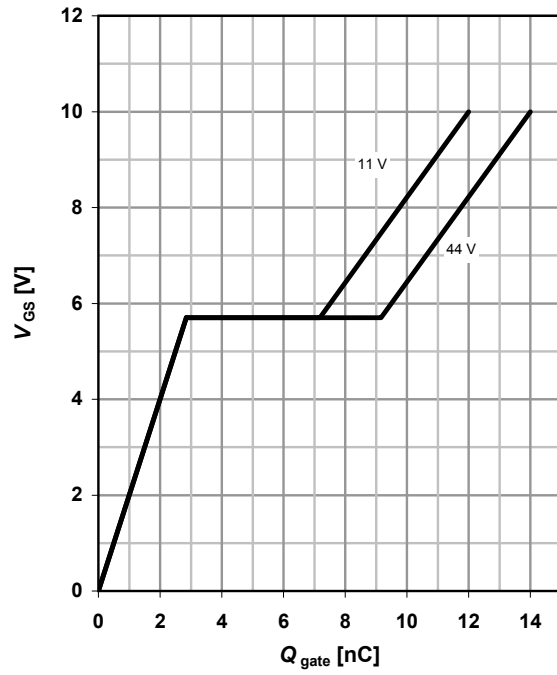
$$E_{AS} = f(T_j)$$

parameter:  $I_D$



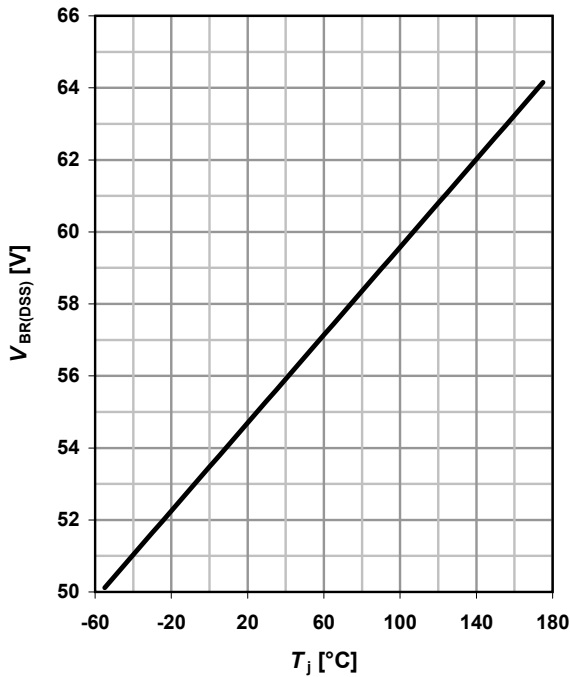
**14 Typ. gate charge**

$$V_{GS} = f(Q_{gate}); I_D = 25 \text{ A pulsed}$$

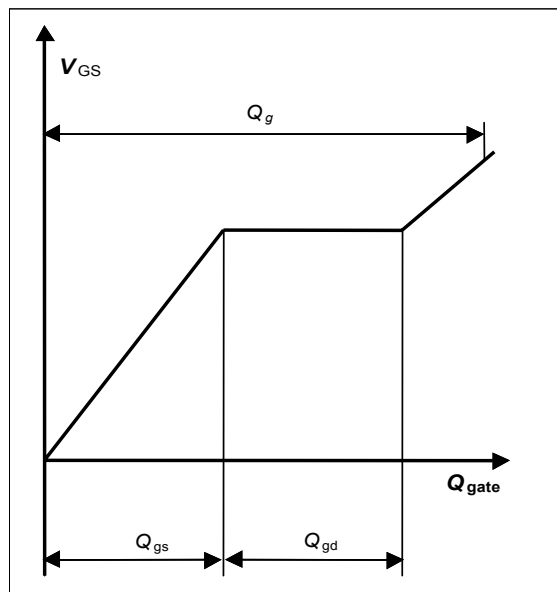


**15 Typ. drain-source breakdown voltage**

$$V_{BR(DSS)} = f(T_j); I_D = 1 \text{ mA}$$



**16 Gate charge waveforms**



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